

# **Device Modeling Report**

COMPONENTS:

DIODE/ GENERAL PURPOSE RECTIFIER/ STANDARD

PART NUMBER: RURD460S

MANUFACTURER: FAIRCHILD

REMARK: TC=150 degree

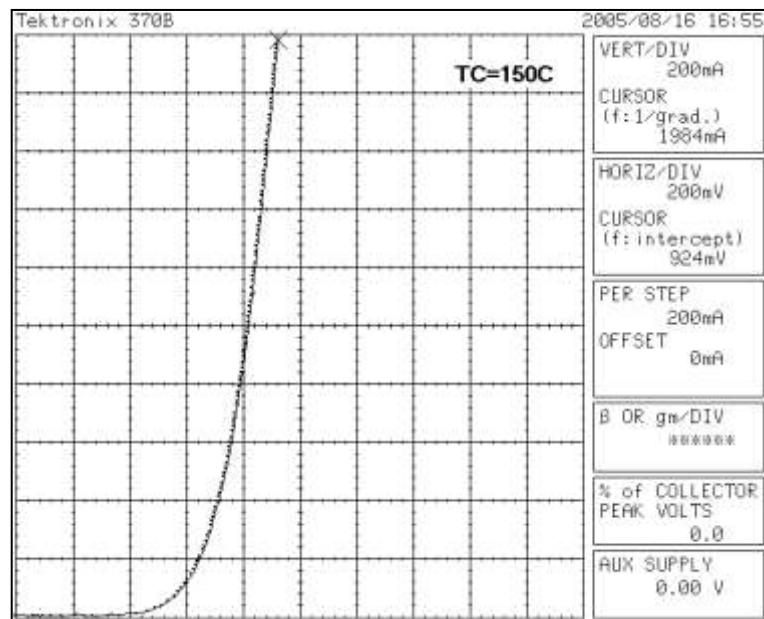


**Bee Technologies Inc.**

| PSpice model parameter | Model description                           |
|------------------------|---|
| IS                     | Saturation Current                          |
| N                      | Emission Coefficient                        |
| RS                     | Series Resistance                           |
| IKF                    | High-injection Knee Current                 |
| CJO                    | Zero-bias Junction Capacitance              |
| M                      | Junction Grading Coefficient                |
| VJ                     | Junction Potential                          |
| ISR                    | Recombination Current Saturation Value      |
| BV                     | Reverse Breakdown Voltage(a positive value) |
| IBV                    | Reverse Breakdown Current(a positive value) |
| TT                     | Transit Time                                |
| EG                     | Energy-band Gap                             |

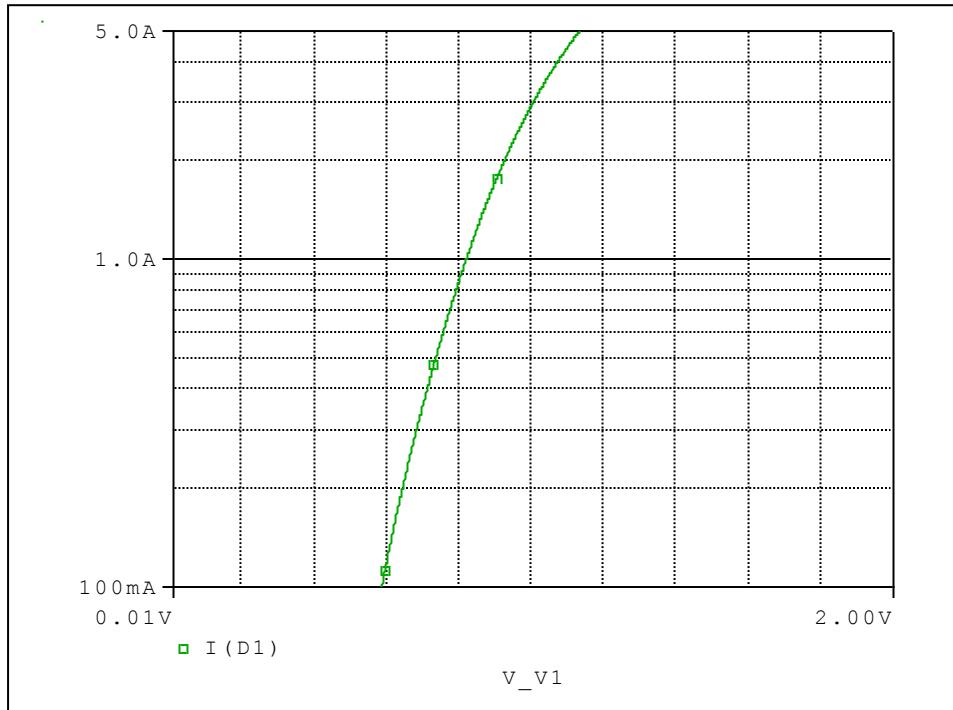
## Forward Current Characteristic

## Reference

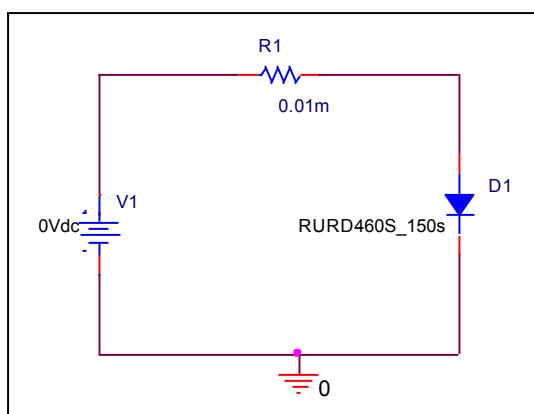


## Forward Current Characteristic

### Circuit Simulation Result

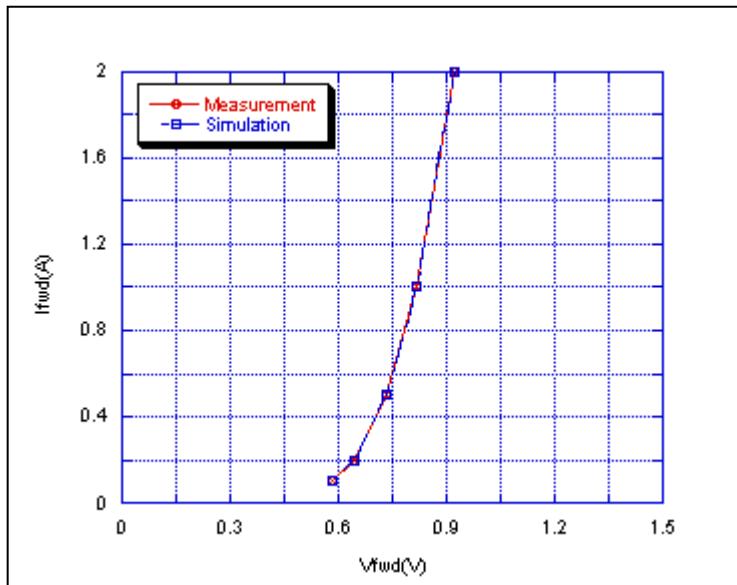


### Evaluation Circuit



## Comparison Graph

### Circuit Simulation Result

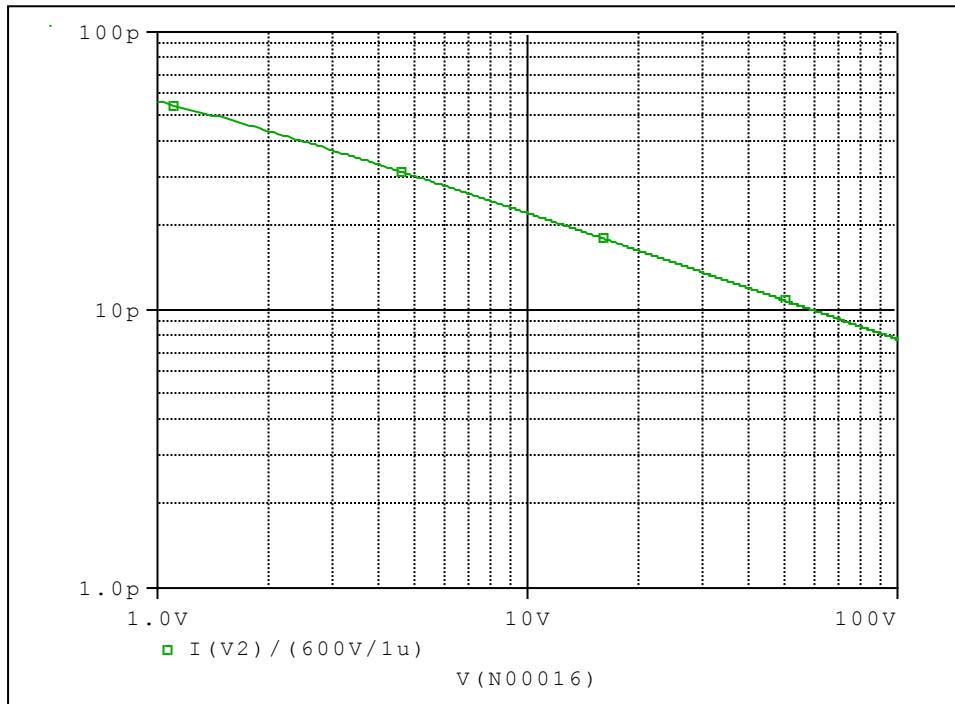


### Simulation Result

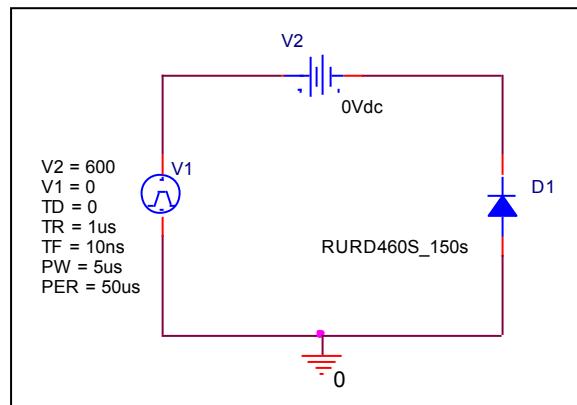
| $I_{fwd}$ (A) | $V_{fwd}$ (V)<br>Measurement | $V_{fwd}$ (V)<br>Simulation | %Error |
|---------------|------------------------------|-----------------------------|--------|
| 0.1           | 0.586                        | 0.585                       | 0.171  |
| 0.2           | 0.642                        | 0.644                       | -0.312 |
| 0.5           | 0.736                        | 0.733                       | 0.408  |
| 1             | 0.818                        | 0.818                       | 0.000  |
| 2             | 0.924                        | 0.922                       | 0.216  |

## Capacitance Characteristic

### Circuit Simulation Result

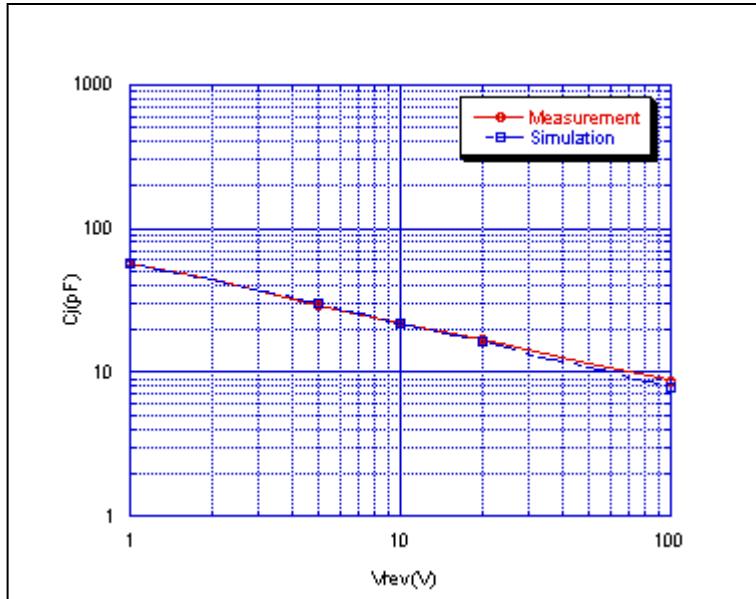


### Evaluation Circuit



## Comparison Graph

### Circuit Simulation Result

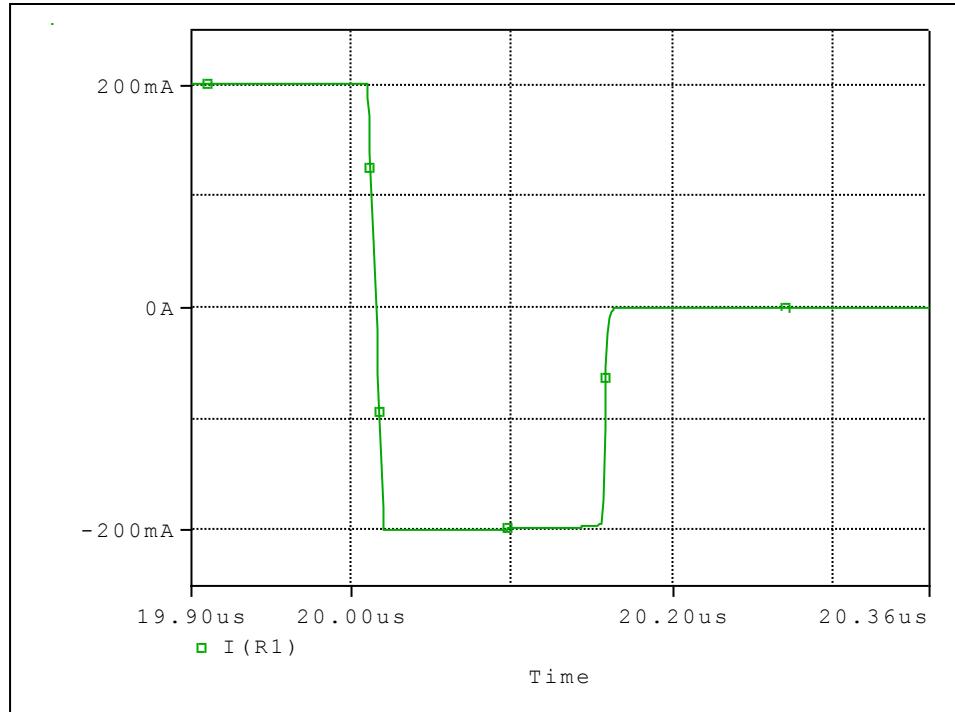


### Simulation Result

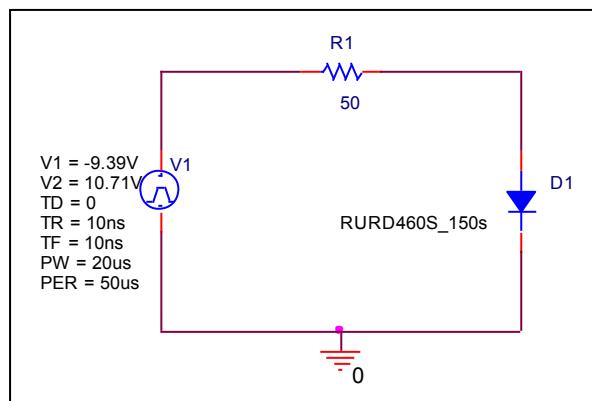
| $V_{rev}$ (V) | $C_j$ (pF)<br>Measurement | $C_j$ (pF)<br>Simulation | %Error |
|---------------|---------------------------|--------------------------|--------|
| 0             | 101.600                   | 101.600                  | 0.000  |
| 1             | 57.300                    | 56.368                   | 1.627  |
| 2             | 43.600                    | 44.000                   | -0.917 |
| 5             | 29.200                    | 30.200                   | -3.425 |
| 10            | 21.700                    | 22.112                   | -1.899 |
| 20            | 16.650                    | 16.365                   | 1.712  |
| 50            | 11.450                    | 10.800                   | 5.677  |

## Reverse Recovery Characteristic

### Circuit Simulation Result



### Evaluation Circuit

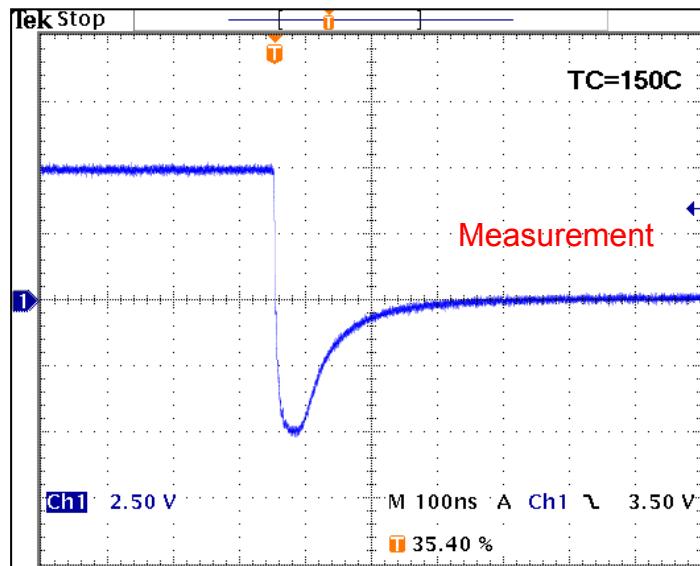


### Compare Measurement vs. Simulation

|              | Measurement |    | Simulation |    | %Error |
|--------------|-------------|----|------------|----|--------|
| $\text{trr}$ | 144.00      | ns | 144.20     | ns | 0.133  |

## Reverse Recovery Characteristic

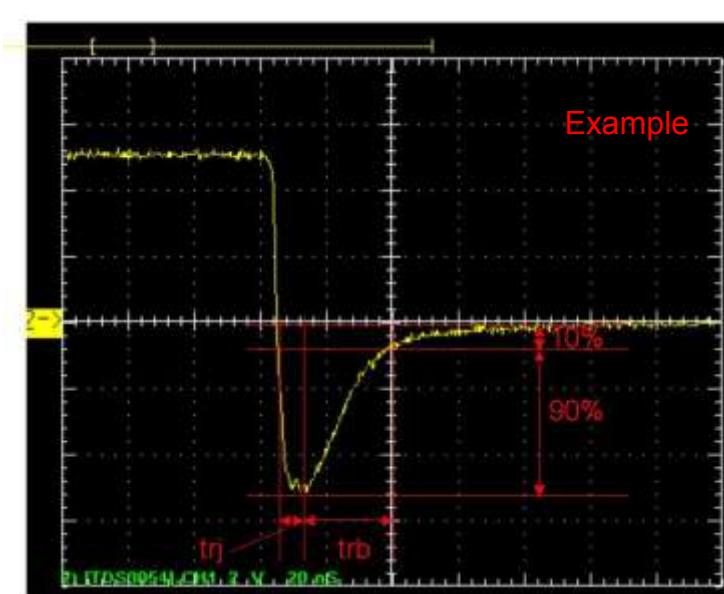
## Reference



Trj =36 (ns)

Trb= 108 (ns)

Conditions: Ifwd=Irev=0.2(A), RI=50



Relation between trj and trb